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Application/Control No.	Applicant(s)/Patent under Reexamination
08/770,792	KOYAMA ET AL.
Examiner	Art Unit
Julie-Huven I Nao	2871

	SEARCHED		
Class	Subclass	Date	Examiner
349	122	10/15/2005	HN
349	151-154	10/15/2005	HN
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
349	122	10/15/2005	HN	
349	151	10/15/2005	HN	
349	154	10/15/2005	HN	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST SEARCHED IN US-PGPUB, USPAT, JPO, EPO, DREWENT AND IBM-TBD (SEE PRINT OUT)	10/15/2005	HN
INTERFERENCE SEARCHED (SEE PRINT OUT)	10/15/2005	HN
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